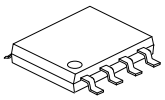
U74LVC1G74

CMOS IC

SINGLE POSITIVE-EDGE-TRIGGERED D-TYPE FLIP-FLOP WITH CLEAR AND PRESET



SOP-8

■ DESCRIPTION

This single positive-edge-triggered D-type flip-flop is designed for 1.65V to 5.5V V_{CC} operation.

A low level at the preset($\overline{PRE}$) or clear ($\overline{CLR}$) input sets or resets the outputs, regardless of the levels of the other inputs .when $\overline{PRE}$ and $\overline{CLR}$ are inactive(high),data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not related directly to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

The device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

■ FEATURES

* Supports 5-V V_{CC} operation
* Inputs accept voltages to 5.5V
* Max t_{pd} of 5.9ns at 3.3V
* Typical V_{OLP}<0.8V at V_{CC}=3.3V, T_A=25°C
* Typical V_{OHV}>2V at V_{CC}=3.3V, T_A=25°C
* Low Power Consumption, I_{CC}=10μA (Max.)
* I_{off} Supports Live Insertion, Partial Power Down Mode, and Back Drive Protection

■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC1G74L-S08-R	U74LVC1G74G-S08-R	SOP-8	Tape Reel

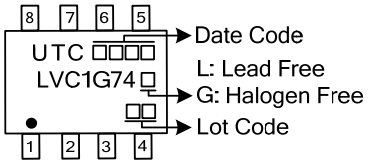
U74LVC1G74G-S08-R

(1)Packing Type — (1) R: Tape Reel

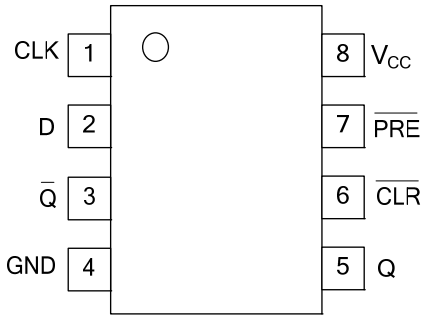
(2)Package Type — (2) S08: SOP-8

(3)Green Package — (3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ PIN CONFIGURATION

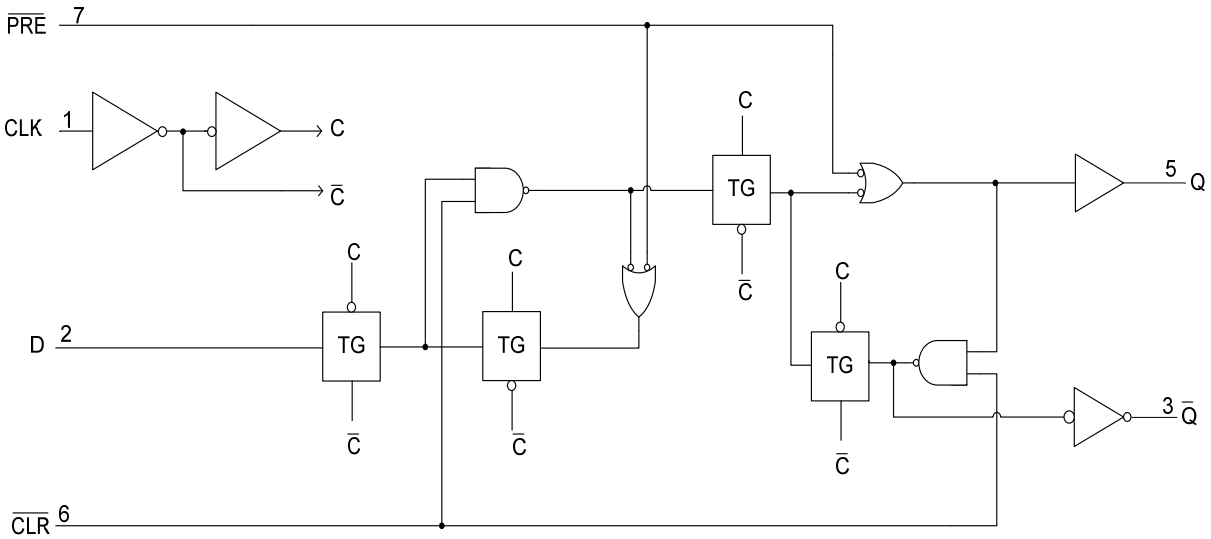


■ FUNCTION TABLE

INPUTS				OUTPUT	
$\overline{PRE}$	$\overline{CLR}$	CLK	D	Q	$\overline{Q}$
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H *	H *
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q0	$\overline{Q}_0$

* This configuration is unstable, it does not persist when $\overline{PRE}$ or $\overline{CLR}$ returns to high level.

■ LOGIC DIAGRAM (positive logic)



■ ABSOLUTE MAXIMUM RATING (unless otherwise specified) (Note 1)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{CC}	-0.5~6.5	V
Input Voltage	V_{IN}	-0.5~ 6.5	V
Voltage range applied to any output in the high-impedance or power-off state	V_{OUT}	-0.5~ 6.5	V
Voltage range applied to any output in the high or low state	V_{OUT}	-0.5~V_{CC}+0.5	V
Input Clamp Current(V_{IN}<0)	I_{IK}	-50	mA
Output Clamp Current(V_{OUT}<0)	I_{OK}	-50	mA
Output Current	I_{OUT}	±50	mA
V_{CC} or GND Current	I_{CC}	±100	mA
Storage Temperature	T_{STG}	-65 ~ +150	°C

Notes: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}		1.65		5.5	V
Input Voltage	V_{IN}		0		5.5	V
Output Voltage	V_{OUT}		0		V_{CC}	V
High-level input voltage	V_{IH}	V_{CC} =1.65V to 1.95V	0.65×V_{CC}			V
		V_{CC}=2.3V to 2.7V	1.7			
		V_{CC} =3V to 3.6V	2			
		V_{CC} =4.5V to 5.5V	0.7×V_{CC}			
Low-level input voltage	V_{IL}	V_{CC} =1.65V to 1.95V			0.35×V_{CC}	V
		V_{CC}=2.3V to 2.7V			0.7	
		V_{CC} =3V to 3.6V			0.8	
		V_{CC} =4.5V to 5.5V			0.3×V_{CC}	
High-level Output Current	I_{OH}	V_{CC} =1.65V			-4	mA
		V_{CC}=2.3V			-8	
		V_{CC} =3V			-16	
					-24	
		V_{CC} =4.5V			-32	
Low-level Output Current	I_{OL}	V_{CC} =1.65V			4	mA
		V_{CC}=2.3V			8	
		V_{CC} =3V			16	
					24	
		V_{CC} =4.5V			32	
Input Transition Rise or Fall Rate	Δt/Δv	V_{CC} =1.8V±0.15V, 2.5V±0.2V			20	ns/V
		V_{CC} =3.3V±0.3V,			10	
		V_{CC} =5V±0.5V,			5	
Operating Temperature	T_A		-40		+85	°C

Note: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.

■ STATIC CHARACTERISTICS

(All typical values are at V_{CC}=3.3V, T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
High-Level Output Voltage	V_{OH}	V_{CC}=1.65V to 5.5V, I_{OH}=-100μA		V_{CC}-0.1			V
		V_{CC}=1.65V, I_{OH}=-4mA		1.2			
		V_{CC}=2.3V, I_{OH}=-8mA		1.9			
		V_{CC}=3V	I_{OH}=-16mA	2.4			
			I_{OH}=-24mA	2.3			
		V_{CC}=4.5V, I_{OH}=-32mA		3.8			
Low-Level Output Voltage	V_{OL}	V_{CC}=1.65V to 5.5V, I_{OL}=100uA				0.1	V
		V_{CC}=1.65V, I_{OL}=4mA				0.45	
		V_{CC}=2.3V, I_{OL}=8mA				0.3	
		V_{CC}=3V	I_{OL}=16mA			0.4	
			I_{OL}=24mA			0.55	
		V_{CC}=4.5V, I_{OH}=32mA				0.55	
Input Leakage Current	$I_{I(LEAK)}$	V_{CC} =0V ~ 5.5V, V_{IN}=5.5V or GND				±5	μA
Power OFF Leakage Current	I_{off}	V_{CC} =0V, V_{IN} or V_{OUT}=5.5V				±10	μA
Quiescent Supply Current	I_Q	V_{CC} = 1.65V to 5.5V, V_{IN}= 5.5V or GND I_{OUT}=0				10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI_Q	V_{CC}=3V to 5.5V, One input at V_{CC}-0.6V, Other inputs at V_{CC} or GND				500	μA
Input Capacitance	C_{IN}	V_{CC} =3.3V, V_{IN}=V_{CC} or GND			5		pF

■ TIMING REQUIREMENTS

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Clock frequency	f_{clock}	V_{CC}=1.8V				80	MHz
		V_{CC}=2.5V				175	MHz
		V_{CC}=3.3V				175	MHz
		V_{CC}=5.0V				200	MHz
Pulse duration	tw	V_{CC}=1.8V	CLK	6.2			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	6.2			ns
		V_{CC}=2.5V	CLK	2.7			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	2.7			ns
		V_{CC}=3.3V	CLK	2.7			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	2.7			ns
		V_{CC}=5.0V	$\overline{PRE}$ or $\overline{CLR}$ Low	2			ns
				2			ns
Setup time before CLK↑ from Data to $\overline{PRE}$ or $\overline{CLR}$ inactive	tsu	V_{CC}=1.8V	CLK	2.9			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	1.9			
		V_{CC}=2.5V	CLK	1.7			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	1.4			
		V_{CC}=3.3V	CLK	1.3			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	1.2			ns
		V_{CC}=5.0V	CLK	1.1			ns
			$\overline{PRE}$ or $\overline{CLR}$ Low	1.0			ns
Hold time, data after CLK↑	th	V_{CC}=1.8V		0			ns
		V_{CC}=2.5V		0.3			ns
		V_{CC}=3.3V		1.2			ns
		V_{CC}=5.0V		0.5			ns

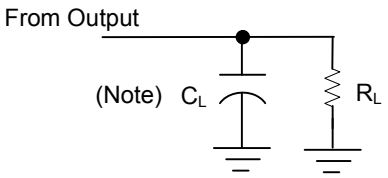
■ SWITCHING CHARACTERISTICS (See Fig. 1 and Fig. 2 for test circuit and waveforms.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Minimum Frequency Response	f_{Max}	V_{CC}=1.8V	80			MHz
		V_{CC}=2.5V	175			MHz
		V_{CC}=3.3V	175			MHz
		V_{CC}=5.0V	200			MHz
Propagation delay from input (CLK) to output(Q)	t_{PLH}/t_{PHL}	V_{CC}=1.8V	4.8		13.4	ns
		V_{CC}=2.5V	2.2		7.1	ns
		V_{CC}=3.3V	2.2		5.9	ns
		V_{CC}=5.0V	1.4		4.1	ns
Propagation delay from input (CLK) to output($\overline{Q}$)	t_{PLH}/t_{PHL}	V_{CC}=1.8V	6		14.4	ns
		V_{CC}=2.5V	3		7.7	ns
		V_{CC}=3.3V	2.6		6.2	ns
		V_{CC}=5.0V	1.6		4.4	ns
Propagation delay from input ($\overline{PRE}$ or $\overline{CLR}$) to output(Q or $\overline{Q}$)	t_{PLH}/t_{PHL}	V_{CC}=1.8V	4.4		12.9	ns
		V_{CC}=2.5V	2.3		7	ns
		V_{CC}=3.3V	1.7		5.9	ns
		V_{CC}=5.0V	1.6		4.1	ns

■ OPERATING CHARACTERISTICS(T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	f=10MHz	V_{CC}=1.8V		35		pF
			V_{CC}=2.5V		35		pF
			V_{CC}=3.3V		37		pF
			V_{CC}=5.0V		40		pF

■ TEST CIRCUIT AND WAVEFORMS

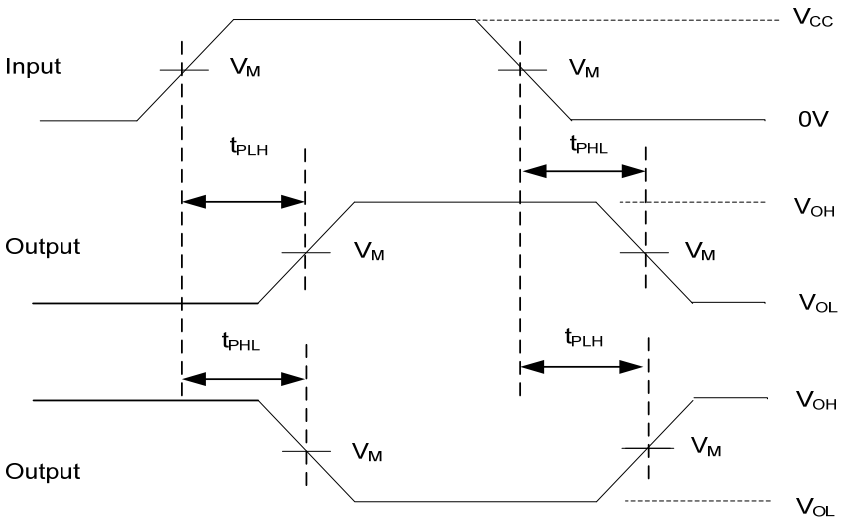


TEST CIRCUIT

Note: C_L includes probe and jig capacitance.

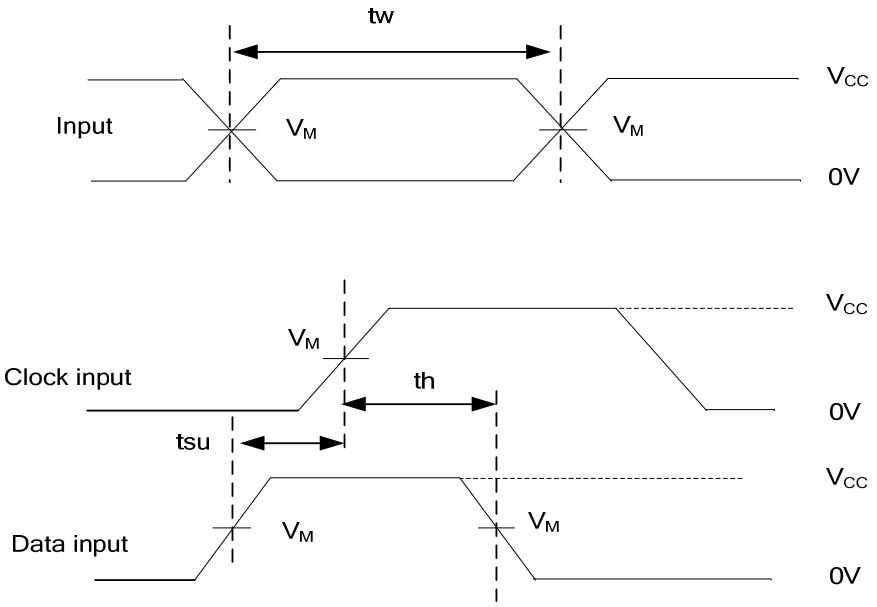
Fig. 1 Load circuitry for switching times.

V_{CC}	Inputs		V_M	C_L	R_L
	V_{IN}	t_R, t_F			
1.8V	V_{CC}	≤2ns	$V_{CC}/2$	30pF	1KΩ
2.5V	V_{CC}	≤2ns	$V_{CC}/2$	30pF	500Ω
3.3V	3V	≤2.5ns	1.5V	50pF	500Ω
5V	V_{CC}	≤2.5ns	$V_{CC}/2$	50pF	500Ω



PROPAGATION DELAY TIMES

■ TEST CIRCUIT AND WAVEFORMS(Cont.)



Note: All input pulses are supplied by generators having the following characteristics: PRR≤10MHz, Z_O=50Ω

Fig. 2 Propagation delay from input to output and input voltage waveforms.